



ELSEVIER

Applied Surface Science 84 (1995) 419–422

applied
surface science

Author index

- Aguiar Colom, R., see Reihs, K. 84 (1995) 107
- Atanassova, E., T. Dimitrova and J. Koprinarova, AES and XPS study of thin RF-sputtered Ta₂O₅ layers 84 (1995) 193
- Balducci, L., see Garbassi, F. 84 (1995) 145
- Ballutaud, D., C. Debiemme-Chouvy, A. Etcheberry, P. de Mierry and L. Svob, Reactivity of III–V and II–VI semiconductors toward hydrogen: surface modification and evolution in air 84 (1995) 187
- Barkshire, I.R., M. Prutton and G.C. Smith, Multi-spectral scanning Auger microscopy of tribological surfaces 84 (1995) 331
- Benítez, J.J., I. Carrizosa and J.A. Odriozola, In situ diffuse reflectance infrared (DRIFTS) identification of active sites in the CO + H₂ reaction over lanthanide-modified Rh/Al₂O₃ catalysts 84 (1995) 391
- Benninghoven, A., see Reihs, K. 84 (1995) 107
- Bermudez, V.M., Adsorption and co-adsorption of boron and oxygen on ordered α -SiC surfaces 84 (1995) 45
- Bertóti, I., M. Mohai, J.L. Sullivan and S.O. Saied, Surface characterisation of plasma-nitrided titanium: an XPS study 84 (1995) 357
- Bertrand, P., see Weng, L.T. 84 (1995) 9
- Bertrand, P., see Piyakis, K. 84 (1995) 227
- Bevk, J., see Kosowsky, S.D. 84 (1995) 179
- Block, J.H., see Cocke, D.L. 84 (1995) 153
- Bouveresse, E., see Friedbacher, G. 84 (1995) 133
- Bracconi, P., see Buisson, L. 84 (1995) 211
- Brübach, J., see Hopkins, J. 84 (1995) 299
- Buckley, A.N. and R. Woods, Comment on 'Scanning tunnelling microscopy studies of galena: the mechanism of oxidation in air' by B.S. Kim, R.A. Hayes, C.A. Prestidge, J. Ralston and R.St.C. Smart 84 (1995) 223
- Buisson, L., P. Bracconi and X. Claudon, Quantitative analysis of the thermal degassing of a beryllium powder 84 (1995) 211
- Carrizosa, I., see Benítez, J.J. 84 (1995) 391
- Caudano, R., see Grégoire, Ch. 84 (1995) 163
- Chenakin, S.P., Initial oxidation kinetics of Fe–Ni single crystals before and after ion bombardment 84 (1995) 91
- Chiurlo, P., see Garbassi, F. 84 (1995) 145
- Chuah, G.K., see Cocke, D.L. 84 (1995) 153
- Claudon, X., see Buisson, L. 84 (1995) 211
- Cocke, D.L., G.K. Chuah, N. Kruse and J.H. Block, Copper oxidation and surface copper oxide stability investigated by pulsed field desorption mass spectrometry 84 (1995) 153
- Cros, A., see Grégoire, Ch. 84 (1995) 163
- De Marco, R. and J. Liesegang, Surface analysis of commercial lead/acid battery grids 84 (1995) 237
- De Mierry, P., see Ballutaud, D. 84 (1995) 187
- Debiemme-Chouvy, C., see Ballutaud, D. 84 (1995) 187
- Deiana, L., see Garbassi, F. 84 (1995) 145
- Deimel, M., see Reihs, K. 84 (1995) 107
- Dey, S.D., see Ray, N. 84 (1995) 203
- Dieckhoff, S., see Gesang, T. 84 (1995) 273
- Dimitrova, T., see Atanassova, E. 84 (1995) 193
- Dodelet, J.P., see Weng, L.T. 84 (1995) 9
- Domingue, A., see Piyakis, K. 84 (1995) 227
- Eaglesham, D.J., see Weir, B.E. 84 (1995) 413
- Etcheberry, A., see Ballutaud, D. 84 (1995) 187
- Fanter, D., see Gesang, T. 84 (1995) 273
- Fedotov, A.K., M.I. Tarasik and A.M. Yanchenko, Carrier transport in heavily doped polycrystalline silicon layers after annealing by a scanning laser beam 84 (1995) 379
- Fei, X., see Wang, J. 84 (1995) 383
- Feldman, L.C., see Weir, B.E. 84 (1995) 413
- Fitzpatrick, J.J., see Hansen, D.C. 84 (1995) 85
- Freer, B.S., see Kosowsky, S.D. 84 (1995) 179
- Friedbacher, G., E. Bouveresse, G. Fuchs, M. Grasserbauer, D. Schwarzbach, R. Haubner and B. Lux, Pre-

- treatment of silicon substrates for CVD diamond deposition studied by atomic force microscopy 84 (1995) 133
 Fuchs, G., see Friedbacher, G. 84 (1995) 133
- Garbassi, F., L. Balducci, P. Chiurlo and L. Deiana, A study of surface modification of silica using XPS, DRIFT and NMR 84 (1995) 145
- Gesang, T., R. Höper, S. Dieckhoff, D. Fanter, A. Hartwig, W. Possart and O.-D. Hennemann, AFM investigations of the initial stages of prepolymer film growth on aluminium 84 (1995) 273
 Gleditzsch, S., see Reihs, K. 84 (1995) 107
 Grasserbauer, M., see Friedbacher, G. 84 (1995) 133
 Grégoire, Ch., J.J. Pireaux, A. Cros and R. Caudano, High Resolution Electron Energy Loss Spectroscopy investigation of the copper/polyphenylquinoxaline interface formation 84 (1995) 163
 Griffiths, K., see Kasza, R.V. 84 (1994) 97
 Grozdanov, I., Solution growth and characterization of silver sulfide films 84 (1995) 325
 Guay, D., see Weng, L.T. 84 (1995) 9
 Gunter, P.L.J., see Van Hardeveld, R.M. 84 (1995) 339
 Guo, S., G. Xue and Y. Qian, Interfacial modification of polymer/metal joints by a two-component coupling system of polybenzimidazole and 2-mercaptobenzimidazole 84 (1995) 351
- Hagenhoff, B., see Reihs, K. 84 (1995) 107
 Hansen, D.C., E. McCafferty, C.W. Lins and J.J. Fitzpatrick, An FT-IR investigation of parabactin adsorbed onto aluminium 84 (1995) 85
 Hartwig, A., see Gesang, T. 84 (1995) 273
 Hatta, A., see Suzuki, Y. 84 (1995) 1
 Haubner, R., see Friedbacher, G. 84 (1995) 133
 Headrick, R.L., see Weir, B.E. 84 (1995) 413
 Hennemann, O.-D., see Gesang, T. 84 (1995) 273
 Holt, S.A., R. Zhao and S. Myhra, Aqueous degradation of Bi-2212 single crystals: an AFM study of surface alteration 84 (1995) 125
 Höper, R., see Gesang, T. 84 (1995) 273
 Hopkins, J., M.R. Leys, J. Brübach, W.C. van der Vleuten and J.H. Wolter, A RHEED study of the dynamics of GaAs and AlGaAs growth on a (001) surface by MBE 84 (1995) 299
 Hsu, C.-H., see Kosowsky, S.D. 84 (1995) 179
- Ichimura, S., see Sekine, S. 84 (1995) 401
 Ionescu, R., C. Moise and A. Vancu, Are modulations of the Schottky surface barrier the only explanation for the gas-sensing effects in sintered SnO₂? 84 (1995) 291
 Ishikawa, K., see Yago, H. 84 (1995) 119
- Jain, A., A.K. Razdan, P.N. Kotru and B.M. Wanklyn, Chemical etching of (100) and (110) faces of flux-grown LaBO₃ crystals 84 (1995) 65
 Jiang, S., D. Peng, X. Zhao, L. Xie and Q. Li, Study on the mechanical and chemical properties of (Ti,Al)N films prepared by DC magnetron sputtering 84 (1995) 373
- Kasza, R.V., K. Griffiths, V.P. Zhdanov and P.R. Norton, Nucleation and island growth during water adsorption at sub-monolayer coverages 84 (1994) 97
 Kinser, D.L., see Wang, P.W. 84 (1995) 75
 Koprinarova, J., see Atanassova, E. 84 (1995) 193
 Kosowsky, S.D., C.-H. Hsu, P.S. Pershan, J. Bevk and B.S. Freer, An X-ray scattering study of SiO_x/Si/Ge(001) 84 (1995) 179
 Kotru, P.N., see Jain, A. 84 (1995) 65
 Kruse, N., see Cocke, D.L. 84 (1995) 153
 Kuipers, E.W., see Van Hardeveld, R.M. 84 (1995) 339
 Kulkarni, G.U., see Rao, C.N.R. 84 (1995) 285
- Lalande, G., see Weng, L.T. 84 (1995) 9
 Larena, A., G. Pinto and F. Millán, Using the Lambert-Beer law for thickness evaluation of photoconductor coatings for recording holograms 84 (1995) 407
 Leclerc, G., see Piyakis, K. 84 (1995) 227
 Lee, S.-P. and M.C. Lin, Laser-induced decomposition of dimethyl cadmium on a quartz substrate 84 (1995) 31
- Leggett, G.J. and J.C. Vickerman, Sample charging during static SIMS studies of polymers 84 (1995) 253
 LeMone, D.V., see Wang, P.W. 84 (1995) 75
 Leys, M.R., see Hopkins, J. 84 (1995) 299
 Lhoest, J.B., see Piyakis, K. 84 (1995) 227
 Li, Q., see Jiang, S. 84 (1995) 373
 Li, Y.S., see Wong, P.C. 84 (1995) 245
 Liesegang, J., see De Marco, R. 84 (1995) 237
 Lin, M.C., see Lee, S.-P. 84 (1995) 31
 Lins, C.W., see Hansen, D.C. 84 (1995) 85
 Lu, L., see Wang, P.W. 84 (1995) 75
 Luftman, H.S., see Weir, B.E. 84 (1995) 413
 Lux, B., see Friedbacher, G. 84 (1995) 133
- McCafferty, E., see Hansen, D.C. 84 (1995) 85
 Millán, F., see Larena, A. 84 (1995) 407
 Mitchell, K.A.R., see Wong, P.C. 84 (1995) 245
 Mohai, M., see Bertóti, I. 84 (1995) 357
 Moise, C., see Ionescu, R. 84 (1995) 291
 Morris, R.E., see Schreifels, J.A. 84 (1995) 23
 Myhra, S., see Holt, S.A. 84 (1995) 125

- Nakazawa, M. and G.A. Somorjai, Coadsorption of water and selected aromatic molecules to model the adhesion of epoxy resins on hydrated surfaces of zinc oxide and iron oxide 84 (1995) 309
- Niemantsverdriet, J.W., see Van Hardeveld, R.M. 84 (1995) 339
- Nomura, T., see Yago, H. 84 (1995) 119
- Norton, P.R., see Kasza, R.V. 84 (1994) 97
- Odriozola, J.A., see Benítez, J.J. 84 (1995) 391
- Peng, D., see Jiang, S. 84 (1995) 373
- Pershan, P.S., see Kosowsky, S.D. 84 (1995) 179
- Pinto, G., see Larena, A. 84 (1995) 407
- Pireaux, J.-J., see Grégoire, Ch. 84 (1995) 163
- Pireaux, J.-J., see Piyakis, K. 84 (1995) 227
- Piyakis, K., E. Sacher, A. Domingue, J.-J. Pireaux, G. Leclerc, P. Bertrand and J.B. Lhoest, A multitechnique analysis of the outermost layers of the Teflon PFA surface 84 (1995) 227
- Possart, W., see Gesang, T. 84 (1995) 273
- Pruyton, M., see Barkshire, I.R. 84 (1995) 331
- Qian, Y., see Guo, S. 84 (1995) 351
- Rajasekar, P., see Ray, N. 84 (1995) 203
- Rajumon, M.K., see Rao, C.N.R. 84 (1995) 285
- Ralston, J., Reply to the "Comment of A.N. Buckley and R. Woods on 'Scanning tunnelling microscopy studies of galena: the mechanism of oxidation in air' by B.S. Kim, R.A. Hayes, C.A. Prestidge, J. Ralston and R.St.C. Smart" 84 (1995) 225
- Rao, C.N.R., V. Vijayakrishnan, G.U. Kulkarni and M.K. Rajumon, A comparative study of the interaction of oxygen with clusters and single-crystal surfaces of nickel 84 (1995) 285
- Rao, C.N.R., see Santra, A.K. 84 (1995) 347
- Ray, N., P. Rajasekar and S.D. Dey, A comparative study of primary ion energy dependence of secondary ion yields from Si and Ge surfaces under inert and reactive ion bombardment 84 (1995) 203
- Razdan, A.K., see Jain, A. 84 (1995) 65
- Reihs, K., R. Aguiar Colom, S. Gleditzsch, M. Deimel, B. Hagenhoff and A. Benninghoven, Chemisorption of poly(methylhydrogensiloxane) on oxide surfaces: a quantitative investigation using static SIMS 84 (1995) 107
- Sacher, E., see Piyakis, K. 84 (1995) 227
- Sagisaka, K., see Suzuki, Y. 84 (1995) 1
- Saied, S.O., see Bertóti, I. 84 (1995) 357
- Santra, A.K. and C.N.R. Rao, Surface alloy formation in Pd/Ag, Cu/Au and Ni/Au bimetallic overlayers 84 (1995) 347
- Schreifels, J.A., N.H. Turner and R.E. Morris, A comparison of X-ray photoelectron spectroscopy and Auger electron spectroscopy depth profiles for magnesium implants 84 (1995) 23
- Schwarzbach, D., see Friedbacher, G. 84 (1995) 133
- Sekine, S., H. Shimizu and S. Ichimura, Composition of sputtered material from Cu-Ni alloy during Xe⁺ ion sputtering at elevated temperatures 84 (1995) 401
- Shimizu, H., see Sekine, S. 84 (1995) 401
- Smith, G.C., see Barkshire, I.R. 84 (1995) 331
- Somorjai, G.A., see Nakazawa, M. 84 (1995) 309
- Sullivan, J.L., see Bertóti, I. 84 (1995) 357
- Suzuki, Y., K. Sagisaka and A. Hatta, Evidence for infrared absorption enhancement of species at the lithium metal/electrolytic solution interface 84 (1995) 1
- Svob, L., see Ballutaud, D. 84 (1995) 187
- Tarasik, M.I., see Fedotov, A.K. 84 (1995) 379
- Turner, N.H., see Schreifels, J.A. 84 (1995) 23
- Vancu, A., see Ionescu, R. 84 (1995) 291
- Van der Vleuten, W.C., see Hopkins, J. 84 (1995) 299
- Van Hardeveld, R.M., P.L.J. Gunter, L.J. van IJzendoorn, W. Wieldraaijer, E.W. Kuipers and J.W. Niemantsverdriet, Deposition of inorganic salts from solution on flat substrates by spin-coating: theory, quantification and application to model catalysts 84 (1995) 339
- Van IJzendoorn, L.J., see Van Hardeveld, R.M. 84 (1995) 339
- Vickerman, J.C., see Leggett, G.J. 84 (1995) 253
- Vijayakrishnan, V., see Rao, C.N.R. 84 (1995) 285
- Wang, J., X. Fei, Z. Yu and G. Zhao, Laser-induced selective deposition of Ni-P alloy on silicon 84 (1995) 383
- Wang, P.W., L.P. Zhang, L. Lu, D.V. LeMone and D.L. Kinser, Surface modification of lead silicate glass under X-ray irradiation 84 (1995) 75
- Wanklyn, B.M., see Jain, A. 84 (1995) 65
- Wei, Y., see Zhang, X.Q. 84 (1995) 267
- Weir, B.E., D.J. Eaglesham, L.C. Feldman, H.S. Luftman and R.L. Headrick, Electron microscopy of the ordered boron 2 × 1 structure buried in crystalline silicon 84 (1995) 413
- Weng, L.T., P. Bertrand, G. Lalande, D. Guay and J.P. Dodelet, Surface characterization by time-of-flight SIMS of a catalyst for oxygen electroreduction:

- | | | | |
|---|---------------|---|---------------|
| pyrolyzed cobalt phthalocyanine-on-carbon black | 84 (1995) 9 | Strain relaxation in GaAs islands on GaP(001) | 84 (1995) 119 |
| Wieldraaijer, W., see Van Hardeveld, R.M. | 84 (1995) 339 | Yanchenko, A.M., see Fedotov, A.K. | 84 (1995) 379 |
| Wolter, J.H., see Hopkins, J. | 84 (1995) 299 | Yang, W.Y., see Zhang, X.Q. | 84 (1995) 267 |
| Wong, P.C., Y.S. Li and K.A.R. Mitchell, Investigations of the interface between magnesium and polyethylene-terephthalate by X-ray photoelectron spectroscopy | 84 (1995) 245 | You, X.Z., see Zhang, X.Q. | 84 (1995) 267 |
| Woods, R., see Buckley, A.N. | 84 (1995) 223 | Yu, Z., see Wang, J. | 84 (1995) 383 |
| Xie, L., see Jiang, S. | 84 (1995) 373 | Zhang, L.P., see Wang, P.W. | 84 (1995) 75 |
| Xue, G., see Guo, S. | 84 (1995) 351 | Zhang, X.Q., W.Y. Yang, X.Z. You and Y. Wei, Preparation and characterization of self-assembly organic multilayer films on silica surface | 84 (1995) 267 |
| Yago, H., T. Nomura and K. Ishikawa, | | Zhao, G., see Wang, J. | 84 (1995) 383 |
| | | Zhao, R., see Holt, S.A. | 84 (1995) 125 |
| | | Zhao, X., see Jiang, S. | 84 (1995) 373 |
| | | Zhdanov, V.P., see Kasza, R.V. | 84 (1994) 97 |



ELSEVIER

Applied Surface Science 84 (1995) 423–432

applied
surface science

Subject index

Alkali metals

- Evidence for infrared absorption enhancement of species at the lithium metal/electrolytic solution interface, Y. Suzuki, K. Sagisaka and A. Hatta 84 (1995) 1

Alloys

- Surface alloy formation in Pd/Ag, Cu/Au and Ni/Au bimetallic overlayers, A.K. Santra and C.N.R. Rao 84 (1995) 347
- Laser-induced selective deposition of Ni–P alloy on silicon, J. Wang, X. Fei, Z. Yu and G. Zhao 84 (1995) 383
- Composition of sputtered material from Cu–Ni alloy during Xe⁺ ion sputtering at elevated temperatures, S. Sekine, H. Shimizu and S. Ichimura 84 (1995) 401

Aluminium

- An FT-IR investigation of parabactin adsorbed onto aluminum, D.C. Hansen, E. McCafferty, C.W. Lins and J.J. Fitzpatrick 84 (1995) 85
- AFM investigations of the initial stages of prepolymer film growth on aluminium, T. Gesang, R. Höper, S. Dieckhoff, D. Fanter, A. Hartwig, W. Possart and O.-D. Hennemann 84 (1995) 273
- A RHEED study of the dynamics of GaAs and AlGaAs growth on a (001) surface by MBE, J. Hopkins, M.R. Leys, J. Brübach, W.C. van der Vleuten and J.H. Wolter 84 (1995) 299
- Study on the mechanical and chemical properties of (Ti,Al)N films prepared by DC magnetron sputtering, S. Jiang, D. Peng, X. Zhao, L. Xie and Q. Li 84 (1995) 373

Aluminium oxide

- In situ diffuse reflectance infrared (DRIFTS) identification of active sites in the CO + H₂ reaction over lanthanide-modified Rh/Al₂O₃ catalysts, J.J. Benítez, I. Carrizosa and J.A. Odriozola 84 (1995) 391

Argon

- A comparative study of primary ion energy dependence of secondary ion yields from Si and Ge surfaces under inert and reactive ion bombardment, N. Ray, P. Rajasekar and S.D. Dey 84 (1995) 203

Atomic force microscopy

- Aqueous degradation of Bi-2212 single crystals: an AFM study of surface alteration, S.A. Holt, R. Zhao and S. Myhra 84 (1995) 125
- Pretreatment of silicon substrates for CVD diamond deposition studied by atomic force microscopy, G. Friedbacher, E. Bouveresse, G. Fuchs, M. Grasserbauer, D. Schwarzbach, R. Haubner and B. Lux 84 (1995) 133
- AFM investigations of the initial stages of prepolymer film growth on aluminium, T. Gesang, R. Höper, S. Dieckhoff, D. Fanter, A. Hartwig, W. Possart and O.-D. Hennemann 84 (1995) 273

Auger electron spectroscopy

- A comparison of X-ray photoelectron spectroscopy and Auger electron spectroscopy depth profiles for magnesium implants, J.A. Schreifels, N.H. Turner and R.E. Morris 84 (1995) 23

- Adsorption and co-adsorption of boron and oxygen on ordered α -SiC surfaces, V.M. Bermudez 84 (1995) 45
- Initial oxidation kinetics of Fe-Ni single crystals before and after ion bombardment, S.P. Chenakin 84 (1995) 91
- AES and XPS study of thin RF-sputtered Ta₂O₅ layers, E. Atanassova, T. Dimitrova and J. Koprinarova 84 (1995) 193
- Multi-spectral scanning Auger microscopy of tribological surfaces, I.R. Barkshire, M. Prutton and G.C. Smith 84 (1995) 331
- Surface alloy formation in Pd/Ag, Cu/Au and Ni/Au bimetallic overlayers, A.K. Santra and C.N.R. Rao 84 (1995) 347
- Study on the mechanical and chemical properties of (Ti,Al)N films prepared by DC magnetron sputtering, S. Jiang, D. Peng, X. Zhao, L. Xie and Q. Li 84 (1995) 373
- Laser-induced selective deposition of Ni-P alloy on silicon, J. Wang, X. Fei, Z. Yu and G. Zhao 84 (1995) 383
- Beryllium**
- Quantitative analysis of the thermal degassing of a beryllium powder, L. Buisson, P. Bracconi and X. Claudon 84 (1995) 211
- Biological materials**
- An FT-IR investigation of parabactin adsorbed onto aluminum, D.C. Hansen, E. McCafferty, C.W. Lins and J.J. Fitzpatrick 84 (1995) 85
- Bismuth**
- Aqueous degradation of Bi-2212 single crystals: an AFM study of surface alteration, S.A. Holt, R. Zhao and S. Myhra 84 (1995) 125
- Borides**
- Chemical etching of (100) and (110) faces of flux-grown LaBO₃ crystals, A. Jain, A.K. Razdan, P.N. Kotru and B.M. Wanklyn 84 (1995) 65
- Boron**
- Adsorption and co-adsorption of boron and oxygen on ordered α -SiC surfaces, V.M. Bermudez 84 (1995) 45
- Electron microscopy of the ordered boron 2 \times 1 structure buried in crystalline silicon, B.E. Weir, D.J. Eaglesham, L.C. Feldman, H.S. Luftman and R.L. Headrick 84 (1995) 413
- Carbon**
- Surface characterization by time-of-flight SIMS of a catalyst for oxygen electroreduction: pyrolyzed cobalt phthalocyanine-on-carbon black, L.T. Weng, P. Bertrand, G. Lalande, D. Guay and J.P. Dodelet 84 (1995) 9
- Carbon monoxide**
- In situ diffuse reflectance infrared (DRIFTS) identification of active sites in the CO + H₂ reaction over lanthanide-modified Rh/Al₂O₃ catalysts, J.J. Benítez, I. Carrizosa and J.A. Odriozola 84 (1995) 391
- Catalysis**
- Surface characterization by time-of-flight SIMS of a catalyst for oxygen electroreduction: pyrolyzed cobalt phthalocyanine-on-carbon black, L.T. Weng, P. Bertrand, G. Lalande, D. Guay and J.P. Dodelet 84 (1995) 9
- Deposition of inorganic salts from solution on flat substrates by spin-coating: theory, quantification and application to model catalysts, R.M. van Hardeveld, P.L.J. Gunter, L.J. van IJzenendoorn, W. Wieldraaijer, E.W. Kuipers and J.W. Niemantsverdriet 84 (1995) 339
- Chemical vapour deposition**
- Pretreatment of silicon substrates for CVD diamond deposition studied by atomic force microscopy, G. Friedbacher, E. Bouveresse, G. Fuchs, M. Grasserbauer, D. Schwarzbach, R. Haubner and B. Lux 84 (1995) 133
- Carrier transport in heavily doped polycrystalline silicon layers after annealing by a scanning laser beam, A.K. Fedotov, M.I. Tarasik and A.M. Yanchenko 84 (1995) 379

Cobalt

- Surface characterization by time-of-flight SIMS of a catalyst for oxygen electro-reduction: pyrolyzed cobalt phthalocyanine-on-carbon black, L.T. Weng, P. Bertrand, G. Lalande, D. Guay and J.P. Dodelet 84 (1995) 9

Copper

- Copper oxidation and surface copper oxide stability investigated by pulsed field desorption mass spectrometry, D.L. Cocke, G.K. Chuah, N. Kruse and J.H. Block 84 (1995) 153
- High Resolution Electron Energy Loss Spectroscopy investigation of the copper/polyphenylquinoxaline interface formation, Ch. Grégoire, J.J. Pireaux, A. Cros and R. Caudano 84 (1995) 163
- Surface alloy formation in Pd/Ag, Cu/Au and Ni/Au bimetallic overlayers, A.K. Santra and C.N.R. Rao 84 (1995) 347
- Composition of sputtered material from Cu-Ni alloy during Xe⁺ ion sputtering at elevated temperatures, S. Sekine, H. Shimizu and S. Ichimura 84 (1995) 401

Depth profiling

- A comparison of X-ray photoelectron spectroscopy and Auger electron spectroscopy depth profiles for magnesium implants, J.A. Schreifels, N.H. Turner and R.E. Morris 84 (1995) 23

Diamond

- Pretreatment of silicon substrates for CVD diamond deposition studied by atomic force microscopy, G. Friedbacher, E. Bouveresse, G. Fuchs, M. Grasserbauer, D. Schwarzbach, R. Haubner and B. Lux 84 (1995) 133

Doping effects

- Electron microscopy of the ordered boron 2 × 1 structure buried in crystalline silicon, B.E. Weir, D.J. Eaglesham, L.C. Feldman, H.S. Luftman and R.L. Headrick 84 (1995) 413

Electron diffraction

- A RHEED study of the dynamics of GaAs and AlGaAs growth on a (001) surface by MBE, J. Hopkins, M.R. Leys, J. Brübach, W.C. van der Vleuten and J.H. Wolter 84 (1995) 299

Electron energy loss spectroscopy

- High Resolution Electron Energy Loss Spectroscopy investigation of the copper/polyphenylquinoxaline interface formation, Ch. Grégoire, J.J. Pireaux, A. Cros and R. Caudano 84 (1995) 163
- A multitechnique analysis of the outermost layers of the Teflon PFA surface, K. Piyakis, E. Sacher, A. Domingue, J.-J. Pireaux, G. Leclerc, P. Bertrand and J.B. Lhoest 84 (1995) 227

Electron microscopy

- Chemical etching of (100) and (110) faces of flux-grown LaBO₃ crystals, A. Jain, A.K. Razdan, P.N. Kotru and B.M. Wanklyn 84 (1995) 65
- Solution growth and characterization of silver sulfide films, I. Grozdanov 84 (1995) 325
- Multi-spectral scanning Auger microscopy of tribological surfaces, I.R. Barkshire, M. Prutton and G.C. Smith 84 (1995) 331
- Laser-induced selective deposition of Ni-P alloy on silicon, J. Wang, X. Fei, Z. Yu and G. Zhao 84 (1995) 383
- Electron microscopy of the ordered boron 2 × 1 structure buried in crystalline silicon, B.E. Weir, D.J. Eaglesham, L.C. Feldman, H.S. Luftman and R.L. Headrick 84 (1995) 413

Epitaxy

- Strain relaxation in GaAs islands on GaP(001), H. Yago, T. Nomura and K. Ishikawa 84 (1995) 119
- A RHEED study of the dynamics of GaAs and AlGaAs growth on a (001) surface by MBE, J. Hopkins, M.R. Leys, J. Brübach, W.C. van der Vleuten and J.H. Wolter 84 (1995) 299

Etching

- Chemical etching of (100) and (110) faces of flux-grown LaBO₃ crystals, A. Jain, A.K. Razdan, P.N. Kotru and B.M. Wanklyn 84 (1995) 65

Gallium arsenide

- Strain relaxation in GaAs islands on GaP(001), H. Yago, T. Nomura and K. Ishikawa 84 (1995) 119
- Reactivity of III-V and II-VI semiconductors toward hydrogen: surface modification and evolution in air, D. Ballutaud, C. Debiemme-Chouvy, A. Etcheberry, P. de Mierry and L. Svob 84 (1995) 187
- A RHEED study of the dynamics of GaAs and AlGaAs growth on a (001) surface by MBE, J. Hopkins, M.R. Leys, J. Brübach, W.C. van der Vleuten and J.H. Wolter 84 (1995) 299

Gallium phosphide

- Strain relaxation in GaAs islands on GaP(001), H. Yago, T. Nomura and K. Ishikawa 84 (1995) 119

Germanium

- An X-ray scattering study of SiO_x/Si/Ge(001), S.D. Kosowsky, C.-H. Hsu, P.S. Pershan, J. Bevk and B.S. Freer 84 (1995) 179
- A comparative study of primary ion energy dependence of secondary ion yields from Si and Ge surfaces under inert and reactive ion bombardment, N. Ray, P. Rajasekar and S.D. Dey 84 (1995) 203

Glass

- Surface modification of lead silicate glass under X-ray irradiation, P.W. Wang, L.P. Zhang, L. Lu, D.V. LeMone and D.L. Kinser 84 (1995) 75

Gold

- Surface alloy formation in Pd/Ag, Cu/Au and Ni/Au bimetallic overlayers, A.K. Santra and C.N.R. Rao 84 (1995) 347

Hydrocarbons

- Chemisorption of poly(methylhydrogen-siloxane) on oxide surfaces: a quantitative investigation using static SIMS, K. Reihs, R. Aguiar Colom, S. Gleditzsch, M. Deimel, B. Hagenhoff and A. Benninghoven 84 (1995) 107

Hydrogen

- Reactivity of III-V and II-VI semiconductors toward hydrogen: surface modification and evolution in air, D. Ballutaud, C. Debiemme-Chouvy, A. Etcheberry, P. de Mierry and L. Svob 84 (1995) 187
- Quantitative analysis of the thermal degassing of a beryllium powder, L. Buisson, P. Bracconi and X. Claudon 84 (1995) 211
- In situ diffuse reflectance infrared (DRIFTS) identification of active sites in the CO + H₂ reaction over lanthanide-modified Rh/Al₂O₃ catalysts, J.J. Benítez, I. Carrizosa and J.A. Odriozola 84 (1995) 391

Infrared spectroscopy

- Evidence for infrared absorption enhancement of species at the lithium metal/electrolytic solution interface, Y. Suzuki, K. Sagisaka and A. Hatta 84 (1995) 1
- An FT-IR investigation of parabactin adsorbed onto aluminum, D.C. Hansen, E. McCafferty, C.W. Lins and J.J. Fitzpatrick 84 (1995) 85
- A study of surface modification of silica using XPS, DRIFT and NMR, F. Garbassi, L. Balducci, P. Chiurlo and L. Deiana 84 (1995) 145
- A multitechnique analysis of the outermost layers of the Teflon PFA surface, K. Piyakis, E. Sacher, A. Domingue, J.-J. Pireaux, G. Leclerc, P. Bertrand and J.B. Lhoest 84 (1995) 227
- In situ diffuse reflectance infrared (DRIFTS) identification of active sites in the CO + H₂ reaction over lanthanide-modified Rh/Al₂O₃ catalysts, J.J. Benítez, I. Carrizosa and J.A. Odriozola 84 (1995) 391
- Using the Lambert-Beer law for thickness evaluation of photoconductor coatings for recording holograms, A. Larena, G. Pinto and F. Millán 84 (1995) 407

Interfaces

- An X-ray scattering study of SiO_x/Si/Ge(001), S.D. Kosowsky, C.-H. Hsu, P.S. Pershan, J. Bevk and B.S. Freer 84 (1995) 179
- Interfacial modification of polymer/metal joints by a two-component coupling system of polybenzimidazole and 2-mercaptobenzimidazole, S. Guo, G. Xue and Y. Qian 84 (1995) 351

Ion bombardment

- Initial oxidation kinetics of Fe-Ni single crystals before and after ion bombardment, S.P. Chenakin 84 (1995) 91
- A comparative study of primary ion energy dependence of secondary ion yields from Si and Ge surfaces under inert and reactive ion bombardment, N. Ray, P. Rajasekar and S.D. Dey 84 (1995) 203

Ion scattering

- Deposition of inorganic salts from solution on flat substrates by spin-coating: theory, quantification and application to model catalysts, R.M. van Hardeveld, P.L.J. Gunter, L.J. van IJzen-doorn, W. Wieldraaijer, E.W. Kuipers and J.W. Niemantsverdriet 84 (1995) 339
- Laser-induced selective deposition of Ni-P alloy on silicon, J. Wang, X. Fei, Z. Yu and G. Zhao 84 (1995) 383

Iron

- Initial oxidation kinetics of Fe-Ni single crystals before and after ion bombardment, S.P. Chenakin 84 (1995) 91
- Coadsorption of water and selected aromatic molecules to model the adhesion of epoxy resins on hydrated surfaces of zinc oxide and iron oxide, M. Nakazawa and G.A. Somorjai 84 (1995) 309

Lanthanides

- Chemical etching of (100) and (110) faces of flux-grown LaBO_3 crystals, A. Jain, A.K. Razdan, P.N. Kotru and B.M. Wanklyn 84 (1995) 65

Laser processing

- Laser-induced decomposition of dimethyl cadmium on a quartz substrate, S.-P. Lee and M.C. Lin 84 (1995) 31
- Carrier transport in heavily doped polycrystalline silicon layers after annealing by a scanning laser beam, A.K. Fedotov, M.I. Tarasik and A.M. Yanchenko 84 (1995) 379
- Laser-induced selective deposition of Ni-P alloy on silicon, J. Wang, X. Fei, Z. Yu and G. Zhao 84 (1995) 383

Lead

- Surface modification of lead silicate glass under X-ray irradiation, P.W. Wang, L.P. Zhang, L. Lu, D.V. LeMone and D.L. Kinser 84 (1995) 75
- Comment on 'Scanning tunnelling microscopy studies of galena: the mechanism of oxidation in air' by B.S. Kim, R.A. Hayes, C.A. Prestidge, J. Ralston and R.St.C. Smart, A.N. Buckley and R. Woods 84 (1995) 223
- Surface analysis of commercial lead/acid battery grids, R. De Marco and J. Liesegang 84 (1995) 237

Low energy electron diffraction

- Adsorption and co-adsorption of boron and oxygen on ordered α -SiC surfaces, V.M. Bermudez 84 (1995) 45

Magnesium

- Investigations of the interface between magnesium and polyethyleneterephthalate by X-ray photoelectron spectroscopy, P.C. Wong, Y.S. Li and K.A.R. Mitchell 84 (1995) 245

Mass spectroscopy

- Copper oxidation and surface copper oxide stability investigated by pulsed field desorption mass spectrometry, D.L. Cocke, G.K. Chuah, N. Kruse and J.H. Block 84 (1995) 153
- Quantitative analysis of the thermal degassing of a beryllium powder, L. Buisson, P. Bracconi and X. Claudon 84 (1995) 211
- Composition of sputtered material from Cu-Ni alloy during Xe^+ ion sputtering at elevated temperatures, S. Sekine, H. Shimizu and S. Ichimura 84 (1995) 401

Metals

- Interfacial modification of polymer/metal joints by a two-component coupling system of polybenzimidazole and 2-mercaptobenzimidazole, S. Guo, G. Xue and Y. Qian 84 (1995) 351

Methane

- Quantitative analysis of the thermal degassing of a beryllium powder, L. Buisson, P. Bracconi and X. Claudon 84 (1995) 211

Multilayers

- Preparation and characterization of self-assembly organic multilayer films on silica surface, X.Q. Zhang, W.Y. Yang, X.Z. You and Y. Wei 84 (1995) 267

Nickel

- Initial oxidation kinetics of Fe-Ni single crystals before and after ion bombardment, S.P. Chenakin 84 (1995) 91
- A comparative study of the interaction of oxygen with clusters and single-crystal surfaces of nickel, C.N.R. Rao, V. Vijaykrishnan, G.U. Kulkarni and M.K. Rajumon 84 (1995) 285
- Surface alloy formation in Pd/Ag, Cu/Au and Ni/Au bimetallic overlayers, A.K. Santra and C.N.R. Rao 84 (1995) 347
- Laser-induced selective deposition of Ni-P alloy on silicon, J. Wang, X. Fei, Z. Yu and G. Zhao 84 (1995) 383
- Composition of sputtered material from Cu-Ni alloy during Xe⁺ ion sputtering at elevated temperatures, S. Sekine, H. Shimizu and S. Ichimura 84 (1995) 401

Nitrides

- Study on the mechanical and chemical properties of (Ti,Al)N films prepared by DC magnetron sputtering, S. Jiang, D. Peng, X. Zhao, L. Xie and Q. Li 84 (1995) 373

Nitrogen

- A comparative study of primary ion energy dependence of secondary ion yields from Si and Ge surfaces under inert and reactive ion bombardment, N. Ray, P. Rajasekar and S.D. Dey 84 (1995) 203
- Surface characterisation of plasma-nitrided titanium: an XPS study, I. Bertóti, M. Mohai, J.L. Sullivan and S.O. Saied 84 (1995) 357

Noble gases

- Composition of sputtered material from Cu-Ni alloy during Xe⁺ ion sputtering at elevated temperatures, S. Sekine, H. Shimizu and S. Ichimura 84 (1995) 401

Nuclear magnetic resonance

- A study of surface modification of silica using XPS, DRIFT and NMR, F. Garbassi, L. Balducci, P. Chiurlo and L. Deiana 84 (1995) 145

Nucleation

- Nucleation and island growth during water adsorption at sub-monolayer coverages, R.V. Kasza, K. Griffiths, V.P. Zhdanov and P.R. Norton 84 (1994) 97

Optical properties

- Preparation and characterization of self-assembly organic multilayer films on silica surface, X.Q. Zhang, W.Y. Yang, X.Z. You and Y. Wei 84 (1995) 267

Organic substances

- Preparation and characterization of self-assembly organic multilayer films on silica surface, X.Q. Zhang, W.Y. Yang, X.Z. You and Y. Wei 84 (1995) 267

Oxidation

- Initial oxidation kinetics of Fe-Ni single crystals before and after ion bombardment, S.P. Chenakin 84 (1995) 91
- Copper oxidation and surface copper oxide stability investigated by pulsed field desorption mass spectrometry, D.L. Cocke, G.K. Chuah, N. Kruse and J.H. Block 84 (1995) 153

Oxides

- Chemisorption of poly(methylhydrogen-siloxane) on oxide surfaces: a quantitative investigation using static SIMS, K. Reihs, R. Aguiar Colom, S. Gleditzsch, M. Deimel, B. Hagenhoff and A. Benninghoven 84 (1995) 107
- AES and XPS study of thin RF-sputtered Ta₂O₅ layers, E. Atanassova, T. Dimitrova and J. Koprinarova 84 (1995) 193
- Coadsorption of water and selected aromatic molecules to model the adhesion of epoxy resins on hydrated surfaces of zinc oxide and iron oxide, M. Nakazawa and G.A. Somorjai 84 (1995) 309

Oxygen

- Adsorption and co-adsorption of boron and oxygen on ordered α -SiC surfaces, V.M. Bermudez 84 (1995) 45
- A comparative study of primary ion energy dependence of secondary ion yields from Si and Ge surfaces under inert and reactive ion bombardment, N. Ray, P. Rajasekar and S.D. Dey 84 (1995) 203
- A comparative study of the interaction of oxygen with clusters and single-crystal surfaces of nickel, C.N.R. Rao, V. Vijayakrishnan, G.U. Kulkarni and M.K. Rajumon 84 (1995) 285

Palladium

- Surface alloy formation in Pd/Ag, Cu/Au and Ni/Au bimetallic overlayers, A.K. Santra and C.N.R. Rao 84 (1995) 347

Phosphorus

- Laser-induced selective deposition of Ni-P alloy on silicon, J. Wang, X. Fei, Z. Yu and G. Zhao 84 (1995) 383

Photochemistry

- Laser-induced decomposition of dimethyl cadmium on a quartz substrate, S.-P. Lee and M.C. Lin 84 (1995) 31

Photoelectron spectroscopy

- A comparison of X-ray photoelectron spectroscopy and Auger electron spectroscopy depth profiles for magnesium implants, J.A. Schreifels, N.H. Turner and R.E. Morris 84 (1995) 23
- Surface modification of lead silicate glass under X-ray irradiation, P.W. Wang, L.P. Zhang, L. Lu, D.V. LeMone and D.L. Kinser 84 (1995) 75
- A study of surface modification of silica using XPS, DRIFT and NMR, F. Garbassi, L. Balducci, P. Chiurlo and L. Deiana 84 (1995) 145
- An X-ray scattering study of $\text{SiO}_x/\text{Si}/\text{Ge}(001)$, S.D. Kosowsky, C.-H. Hsu, P.S. Pershan, J. Bevk and B.S. Freer 84 (1995) 179
- Reactivity of III-V and II-VI semiconductors toward hydrogen: surface modification and evolution in air, D. Ballutaud, C. Debiemme-Chouvy, A. Etcheberry, P. de Mierry and L. Svob 84 (1995) 187

- AES and XPS study of thin RF-sputtered Ta_2O_5 layers, E. Atanassova, T. Dimitrova and J. Koprinarova 84 (1995) 193
- Comment on 'Scanning tunnelling microscopy studies of galena: the mechanism of oxidation in air' by B.S. Kim, R.A. Hayes, C.A. Prestidge, J. Ralston and R.St.C. Smart, A.N. Buckley and R. Woods 84 (1995) 223
- Surface analysis of commercial lead/acid battery grids, R. De Marco and J. Liesegang 84 (1995) 237
- Investigations of the interface between magnesium and polyethyleneterephthalate by X-ray photoelectron spectroscopy, P.C. Wong, Y.S. Li and K.A.R. Mitchell 84 (1995) 245
- A comparative study of the interaction of oxygen with clusters and single-crystal surfaces of nickel, C.N.R. Rao, V. Vijayakrishnan, G.U. Kulkarni and M.K. Rajumon 84 (1995) 285
- Surface characterisation of plasma-nitrided titanium: an XPS study, I. Bertóti, M. Mohai, J.L. Sullivan and S.O. Saied 84 (1995) 357
- Laser-induced selective deposition of Ni-P alloy on silicon, J. Wang, X. Fei, Z. Yu and G. Zhao 84 (1995) 383

Photoemission

- Surface alloy formation in Pd/Ag, Cu/Au and Ni/Au bimetallic overlayers, A.K. Santra and C.N.R. Rao 84 (1995) 347

Plasma processing

- Surface characterisation of plasma-nitrided titanium: an XPS study, I. Bertóti, M. Mohai, J.L. Sullivan and S.O. Saied 84 (1995) 357

Polymers

- Surface characterization by time-of-flight SIMS of a catalyst for oxygen electroreduction: pyrolyzed cobalt phthalocyanine-on-carbon black, L.T. Weng, P. Bertrand, G. Lalande, D. Guay and J.P. Dodelet 84 (1995) 9
- High Resolution Electron Energy Loss Spectroscopy investigation of the copper/polyphenylquinoxaline interface formation, Ch. Grégoire, J.J. Pireaux, A. Cros and R. Caudano 84 (1995) 163

- A multitechnique analysis of the outermost layers of the Teflon PFA surface, K. Piyakis, E. Sacher, A. Domingue, J.-J. Pireaux, G. Leclerc, P. Bertrand and J.B. Lhoest 84 (1995) 227
- Investigations of the interface between magnesium and polyethyleneterephthalate by X-ray photoelectron spectroscopy, P.C. Wong, Y.S. Li and K.A.R. Mitchell 84 (1995) 245
- Sample charging during static SIMS studies of polymers, G.J. Leggett and J.C. Vickerman 84 (1995) 253
- AFM investigations of the initial stages of prepolymer film growth on aluminium, T. Gesang, R. Höper, S. Dieckhoff, D. Fanter, A. Hartwig, W. Possart and O.-D. Hennemann 84 (1995) 273
- Coadsorption of water and selected aromatic molecules to model the adhesion of epoxy resins on hydrated surfaces of zinc oxide and iron oxide, M. Nakazawa and G.A. Somorjai 84 (1995) 309
- Interfacial modification of polymer/metal joints by a two-component coupling system of polybenzimidazole and 2-mercaptobenzimidazole, S. Guo, G. Xue and Y. Qian 84 (1995) 351
- Using the Lambert-Beer law for thickness evaluation of photoconductor coatings for recording holograms, A. Larena, G. Pinto and F. Millán 84 (1995) 407
- Radiation damage*
- Surface modification of lead silicate glass under X-ray irradiation, P.W. Wang, L.P. Zhang, L. Lu, D.V. LeMone and D.L. Kinser 84 (1995) 75
- Raman scattering*
- Interfacial modification of polymer/metal joints by a two-component coupling system of polybenzimidazole and 2-mercaptobenzimidazole, S. Guo, G. Xue and Y. Qian 84 (1995) 351
- Rhodium*
- In situ diffuse reflectance infrared (DRIFTS) identification of active sites in the CO + H₂ reaction over lanthanide-modified Rh/Al₂O₃ catalysts, J.J. Benítez, I. Carrizosa and J.A. Odriozola 84 (1995) 391
- Scanning tunneling microscopy*
- Comment on 'Scanning tunnelling microscopy studies of galena: the mechanism of oxidation in air' by B.S. Kim, R.A. Hayes, C.A. Prestidge, J. Ralston and R.St.C. Smart, A.N. Buckley and R. Woods 84 (1995) 223
- Reply to the "Comment of A.N. Buckley and R. Woods on 'Scanning tunnelling microscopy studies of galena: the mechanism of oxidation in air' by B.S. Kim, R.A. Hayes, C.A. Prestidge, J. Ralston and R.St.C. Smart", J. Ralston 84 (1995) 225
- Schottky barrier*
- Are modulations of the Schottky surface barrier the only explanation for the gas-sensing effects in sintered SnO₂?, R. Ionescu, C. Moise and A. Vancu 84 (1995) 291
- Secondary ion mass spectrometry*
- Surface characterization by time-of-flight SIMS of a catalyst for oxygen electroreduction: pyrolyzed cobalt phthalocyanine-on-carbon black, L.T. Weng, P. Bertrand, G. Lalande, D. Guay and J.P. Dodelet 84 (1995) 9
- Chemisorption of poly(methylhydrogen-siloxane) on oxide surfaces: a quantitative investigation using static SIMS, K. Reihls, R. Aguiar Colom, S. Gleditzsch, M. Deimel, B. Hagenhoff and A. Benninghoven 84 (1995) 107
- A multitechnique analysis of the outermost layers of the Teflon PFA surface, K. Piyakis, E. Sacher, A. Domingue, J.-J. Pireaux, G. Leclerc, P. Bertrand and J.B. Lhoest 84 (1995) 227
- Sample charging during static SIMS studies of polymers, G.J. Leggett and J.C. Vickerman 84 (1995) 253
- Electron microscopy of the ordered boron 2 × 1 structure buried in crystalline silicon, B.E. Weir, D.J. Eaglesham, L.C. Feldman, H.S. Luftman and R.L. Headrick 84 (1995) 413
- Semiconductors*
- Reactivity of III-V and II-VI semiconductors toward hydrogen: surface modification and evolution in air, D. Ballutaud, C. Debiemme-Chouvy, A. Etcheberry, P. de Mierry and L. Svob 84 (1995) 187

Silane

- A study of surface modification of silica using XPS, DRIFT and NMR, F. Garbassi, L. Balducci, P. Chiurlo and L. Deiana

84 (1995) 145

Silicon

- Pretreatment of silicon substrates for CVD diamond deposition studied by atomic force microscopy, G. Friedbacher, E. Bouveresse, G. Fuchs, M. Grasserbauer, D. Schwarzbach, R. Haubner and B. Lux

84 (1995) 133

- A study of surface modification of silica using XPS, DRIFT and NMR, F. Garbassi, L. Balducci, P. Chiurlo and L. Deiana

84 (1995) 145

- An X-ray scattering study of SiO_x/Si/Ge(001), S.D. Kosowsky, C.-H. Hsu, P.S. Pershan, J. Bevk and B.S. Freer

84 (1995) 179

- A comparative study of primary ion energy dependence of secondary ion yields from Si and Ge surfaces under inert and reactive ion bombardment, N. Ray, P. Rajasekar and S.D. Dey

84 (1995) 203

- Carrier transport in heavily doped polycrystalline silicon layers after annealing by a scanning laser beam, A.K. Fedotov, M.I. Tarasik and A.M. Yanchenko

84 (1995) 379

- Laser-induced selective deposition of Ni-P alloy on silicon, J. Wang, X. Fei, Z. Yu and G. Zhao

84 (1995) 383

- Electron microscopy of the ordered boron 2 × 1 structure buried in crystalline silicon, B.E. Weir, D.J. Eaglesham, L.C. Feldman, H.S. Luftman and R.L. Headrick

84 (1995) 413

Silicon carbide

- Adsorption and co-adsorption of boron and oxygen on ordered α -SiC surfaces, V.M. Bermudez

84 (1995) 45

Silicon oxide

- An X-ray scattering study of SiO_x/Si/Ge(001), S.D. Kosowsky, C.-H. Hsu, P.S. Pershan, J. Bevk and B.S. Freer

84 (1995) 179

Silver

- Solution growth and characterization of silver sulfide films, I. Grozdanov

84 (1995) 325

- Surface alloy formation in Pd/Ag, Cu/Au and Ni/Au bimetallic overlayers, A.K. Santra and C.N.R. Rao

84 (1995) 347

Sputter deposition

- AES and XPS study of thin RF-sputtered Ta₂O₅ layers, E. Atanassova, T. Dimitrova and J. Koprinarova

84 (1995) 193

- Study on the mechanical and chemical properties of (Ti,Al)N films prepared by DC magnetron sputtering, S. Jiang, D. Peng, X. Zhao, L. Xie and Q. Li

84 (1995) 373

Sputtering

- Composition of sputtered material from Cu-Ni alloy during Xe⁺ ion sputtering at elevated temperatures, S. Sekine, H. Shimizu and S. Ichimura

84 (1995) 401

Sulphides

- Comment on 'Scanning tunnelling microscopy studies of galena: the mechanism of oxidation in air' by B.S. Kim, R.A. Hayes, C.A. Prestidge, J. Ralston and R.St.C. Smart, A.N. Buckley and R. Woods

84 (1995) 223

- Solution growth and characterization of silver sulfide films, I. Grozdanov

84 (1995) 325

Superconductivity

- Aqueous degradation of Bi-2212 single crystals: an AFM study of surface alteration, S.A. Holt, R. Zhao and S. Myhra

84 (1995) 125

Tantalum

- AES and XPS study of thin RF-sputtered Ta₂O₅ layers, E. Atanassova, T. Dimitrova and J. Koprinarova

84 (1995) 193

Thermal desorption

- Quantitative analysis of the thermal degassing of a beryllium powder, L. Buisson, P. Bracconi and X. Claudon

84 (1995) 211

- Coadsorption of water and selected aromatic molecules to model the adhesion of epoxy resins on hydrated surfaces of zinc oxide and iron oxide, M. Nakazawa and G.A. Somorjai

84 (1995) 309

Thin films

- Pretreatment of silicon substrates for CVD diamond deposition studied by atomic force microscopy, G. Friedbacher, E. Bouveresse, G. Fuchs, M. Grasserbauer, D. Schwarzbach, R. Haubner and B. Lux 84 (1995) 133
- AES and XPS study of thin RF-sputtered Ta₂O₅ layers, E. Atanassova, T. Dimitrova and J. Koprinarova 84 (1995) 193
- Solution growth and characterization of silver sulfide films, I. Grozdanov 84 (1995) 325
- Carrier transport in heavily doped polycrystalline silicon layers after annealing by a scanning laser beam, A.K. Fedotov, M.I. Tarasik and A.M. Yanchenko 84 (1995) 379
- Using the Lambert-Beer law for thickness evaluation of photoconductor coatings for recording holograms, A. Larena, G. Pinto and F. Millán 84 (1995) 407

Time of flight techniques

- Surface characterization by time-of-flight SIMS of a catalyst for oxygen electroreduction: pyrolyzed cobalt phthalocyanine-on-carbon black, L.T. Weng, P. Bertrand, G. Lalande, D. Guay and J.P. Dodelet 84 (1995) 9
- A multitechnique analysis of the outermost layers of the Teflon PFA surface, K. Piyakis, E. Sacher, A. Domingue, J.-J. Pireaux, G. Leclerc, P. Bertrand and J.B. Lhoest 84 (1995) 227
- Composition of sputtered material from Cu-Ni alloy during Xe⁺ ion sputtering at elevated temperatures, S. Sekine, H. Shimizu and S. Ichimura 84 (1995) 401

Tin oxide

- Are modulations of the Schottky surface barrier the only explanation for the gas-sensing effects in sintered SnO₂?, R. Ionescu, C. Moise and A. Vancu 84 (1995) 291

Titanium

- Surface characterisation of plasma-nitrided titanium: an XPS study, I. Bertóti, M. Mohai, J.L. Sullivan and S.O. Saied 84 (1995) 357

- Study on the mechanical and chemical properties of (Ti,Al)N films prepared by DC magnetron sputtering, S. Jiang, D. Peng, X. Zhao, L. Xie and Q. Li 84 (1995) 373

Tribology

- Multi-spectral scanning Auger microscopy of tribological surfaces, I.R. Barkshire, M. Prutton and G.C. Smith 84 (1995) 331

Water

- Nucleation and island growth during water adsorption at sub-monolayer coverages, R.V. Kasza, K. Griffiths, V.P. Zhdanov and P.R. Norton 84 (1994) 97
- Quantitative analysis of the thermal degassing of a beryllium powder, L. Buisson, P. Bracconi and X. Claudon 84 (1995) 211
- Coadsorption of water and selected aromatic molecules to model the adhesion of epoxy resins on hydrated surfaces of zinc oxide and iron oxide, M. Nakazawa and G.A. Somorjai 84 (1995) 309

X-ray diffraction

- Surface analysis of commercial lead/acid battery grids, R. De Marco and J. Liesegang 84 (1995) 237
- Solution growth and characterization of silver sulfide films, I. Grozdanov 84 (1995) 325
- Study on the mechanical and chemical properties of (Ti,Al)N films prepared by DC magnetron sputtering, S. Jiang, D. Peng, X. Zhao, L. Xie and Q. Li 84 (1995) 373

X-ray scattering

- An X-ray scattering study of SiO_x/Si/Ge(001), S.D. Kosowsky, C.-H. Hsu, P.S. Pershan, J. Bevk and B.S. Freer 84 (1995) 179

Zinc

- Coadsorption of water and selected aromatic molecules to model the adhesion of epoxy resins on hydrated surfaces of zinc oxide and iron oxide, M. Nakazawa and G.A. Somorjai 84 (1995) 309